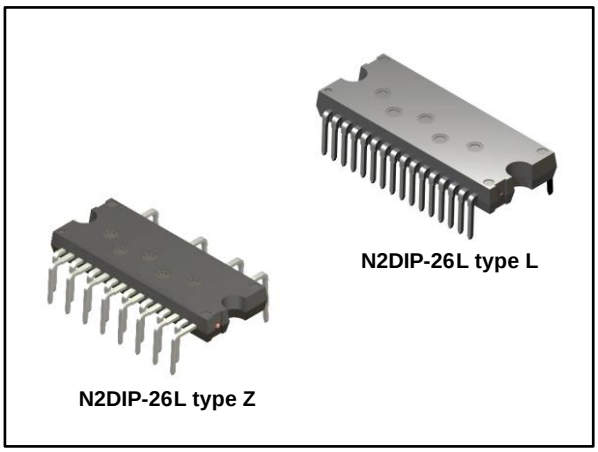
STIPQ5M60T-HL, STIPQ5M60T-HZ

SLLIMM™ nano - 2nd series IPM, 3-phase inverter, 5 A, 1.0 Ω max., 600 V N-channel MDmesh™ DM2

Datasheet - production data



Features

- IPM 5 A, 600 V, $R_{DS(on)}$ = 1.0 Ω, 3-phase MOSFET inverter bridge including control ICs for gate driving
- Optimized for low electromagnetic interference
- 3.3 V, 5 V, 15 V CMOS/TTL input comparators with hysteresis and pull-down/pull-up resistors
- Undervoltage lockout
- Internal bootstrap diode
- Interlocking function
- Smart shutdown function
- Comparator for fault protection against overtemperature and overcurrent
- Op-amp for advanced current sensing
- Optimized pinout for easy board layout
- NTC for temperature control (UL 1434 CA 2 and 4)
- Isolation ratings of 1500 Vrms/min.
- UL recognition: UL 1557 file E81734

Applications

- 3-phase inverters for motor drives
- Dish washers, refrigerator compressors, heating systems, air-conditioning fans, draining and recirculation pumps

Description

This SLLIMM (small low-loss intelligent molded module) nano provides a compact, high performance AC motor drive in a simple, rugged design. It is composed of six N-channel MDmesh DM2 MOSFETs with intrinsic fast recovery diode and three half-bridge HVICs for gate driving, providing low electromagnetic interference (EMI) characteristics with optimized switching speed. The package is designed to allow a better and easy screw on heatsink. It is optimized for thermal performance and compactness in built-in motor applications, or other low power applications where assembly space is limited. This IPM includes an operational amplifier, completely uncommitted, and a comparator that can be used to design a fast and efficient protection circuit. SLLIMM™ is a trademark of STMicroelectronics.

Table 1: Device summary

Order code	Marking	Package	Packing
STIPQ5M60T-HL	IPQ5M60T-HL	N2DIP-26L type L	Tube
STIPQ5M60T-HZ	IPQ5M60T-HZ	N2DIP-26L type Z	Tube

This is information on a product in full production.

Contents

1 Internal schematic diagram and pin configuration

Figure 1: Internal schematic diagram

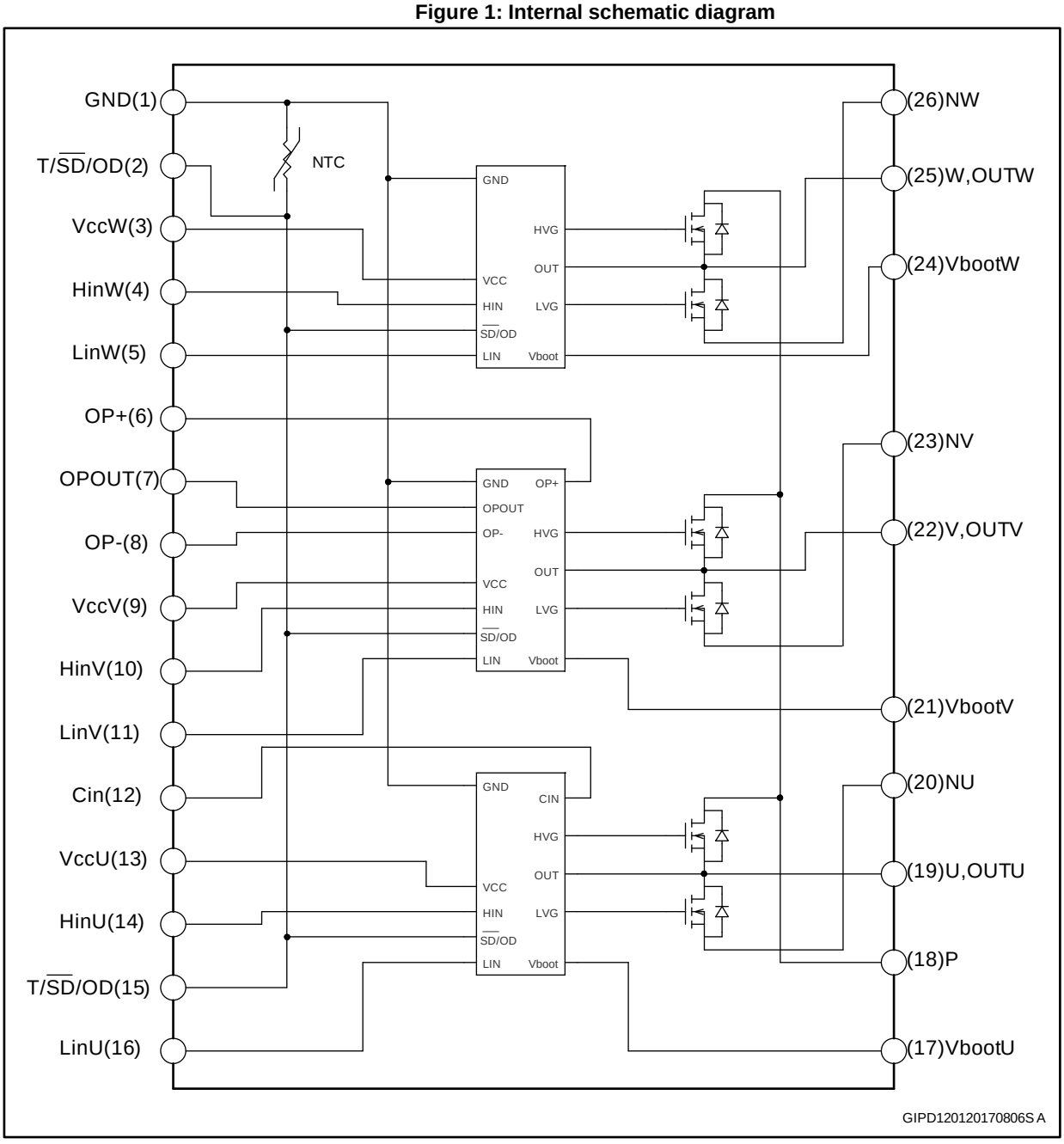


Table 2: Pin description

Pin	Symbol	Description
1	GND	Ground
2	T/$\overline{SD}$/OD	NTC thermistor terminal / shutdown logic input (active low) / open-drain (comparator output)
3	V_{CC} W	Low voltage power supply W phase
4	HIN W	High-side logic input for W phase
5	LIN W	Low-side logic input for W phase
6	OP+	Op-amp non inverting input
7	OP_{OUT}	Op-amp output
8	OP-	Op-amp inverting input
9	V_{CC} V	Low voltage power supply V phase
10	HIN V	High-side logic input for V phase
11	LIN V	Low-side logic input for V phase
12	CIN	Comparator input
13	V_{CC} U	Low voltage power supply for U phase
14	HIN U	High-side logic input for U phase
15	T/$\overline{SD}$/OD	NTC thermistor terminal / shutdown logic input (active low) / open-drain (comparator output)
16	LIN U	Low-side logic input for U phase
17	V_{BOOT} U	Bootstrap voltage for U phase
18	P	Positive DC input
19	U, OUT_U	U phase output
20	N_U	Negative DC input for U phase
21	V_{BOOT} V	Bootstrap voltage for V phase
22	V, OUT_V	V phase output
23	N_V	Negative DC input for V phase
24	V_{BOOT} W	Bootstrap voltage for W phase
25	W, OUT_W	W phase output
26	N_W	Negative DC input for W phase

2 Electrical ratings

2.1 Absolute maximum ratings

Table 3: Inverter part

Symbol	Parameter	Value	Unit
V_{DSS}	MOSFET blocking voltage (or drain-source voltage) for each MOSFET (V_{IN}(1)= 0)	600	V
± I_D	Continuous current each MOSFET	5	A
± I_{DP}(2)	Peak drain current each MOSFET (less than 1 ms)	10	A
P_{TOT}	Each MOSFET total dissipation at T_C = 25 °C	12.8	W

Notes:

(1)Applied among HINi, LINi and GND for i = U, V, W.

(2)Pulse width limited by max. junction temperature.

Table 4: Control part

Symbol	Parameter	Min.	Max.	Unit
V_{OUT}	Output voltage applied among OUT_U, OUT_V, OUT_W - GND	V_{boot} - 21	V_{boot} + 0.3	V
V_{CC}	Low voltage power supply	- 0.3	21	V
V_{CIN}	Comparator input voltage	- 0.3	V_{CC} + 0.3	V
V_{op+}	Op-amp non-inverting input	- 0.3	V_{CC} + 0.3	V
V_{op-}	Op-amp inverting input	- 0.3	V_{CC} + 0.3	V
V_{boot}	Bootstrap voltage	- 0.3	620	V
V_{IN}	Logic input voltage applied among HIN, LIN and GND	- 0.3	15	V
$V_{T/\overline{SD}/OD}$	Open-drain voltage	- 0.3	15	V
$\Delta V_{OUT/dT}$	Allowed output slew rate		50	V/ns

Table 5: Total system

Symbol	Parameter	Value	Unit
V_{ISO}	Isolation withstand voltage applied on each pin and heatsink plate (AC voltage, t = 60 s)	1500	V
T_j	Power chip operating junction temperature	-40 to 150	°C
T_C	Module case operation temperature	-40 to 125	°C

2.2 Thermal data

Table 6: Thermal data

Symbol	Parameter	Value	Unit
$R_{th(j-c)}$	Thermal resistance junction-case single MOSFET	9.8	°C/W

3 Electrical characteristics

T_J = 25 °C unless otherwise specified.

3.1 Inverter part

Table 7: Static

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
I_{DSS}	Zero-gate voltage drain current	V_{DS} = 600 V, V_{CC} = 15 V, V_{Boot} = 15 V			1	mA
$V_{(BR)DSS}$	Drain-source breakdown voltage	V_{CC}= V_{boot} = 15 V, V_{IN}(1) = 0 V, I_D = 1 mA	600			V
$R_{DS(on)}$	Static drain source turn-on resistance	V_{CC} = V_{boot} = 15 V, V_{IN}(1)= 0 to 5 V, I_D = 2.5 A		0.8	1.0	Ω
V_{SD}	Drain-source diode forward voltage	V_{IN}(1) = 0 “logic state”, I_D = 5 A		1.25	1.8	V

Notes:

(1)Applied among HINx, LINx and GND for x = U, V, W.

Table 8: Inductive load switching time and energy

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
t_{on}(1)	Turn-on time	V_{DD} = 300 V, V_{CC} = V_{boot} = 15 V, V_{IN}(2) = 0 to 5 V, I_C = 2.5 A (see *Figure 3: "Switching time definition"*)	-	325	-	ns
$t_{c(on)}$(1)	Crossover time (on)		-	113	-	
t_{off}(1)	Turn-off time		-	380	-	
$t_{c(off)}$(1)	Crossover time (off)		-	37	-	
t_{rr}	Reverse recovery time		-	140	-	
E_{on}	Turn-on switching energy		-	88	-	µJ
E_{off}	Turn-off switching energy		-	9	-	

Notes:

(1)t_{ON} and t_{OFF} include the propagation delay time of the internal drive. $t_{C(ON)}$ and $t_{C(OFF)}$ are the switching time of MOSFET itself under the internally given gate driving conditions.

(2)Applied among HINx, LINx and GND for x = U, V, W.

Figure 2: Switching time test circuit

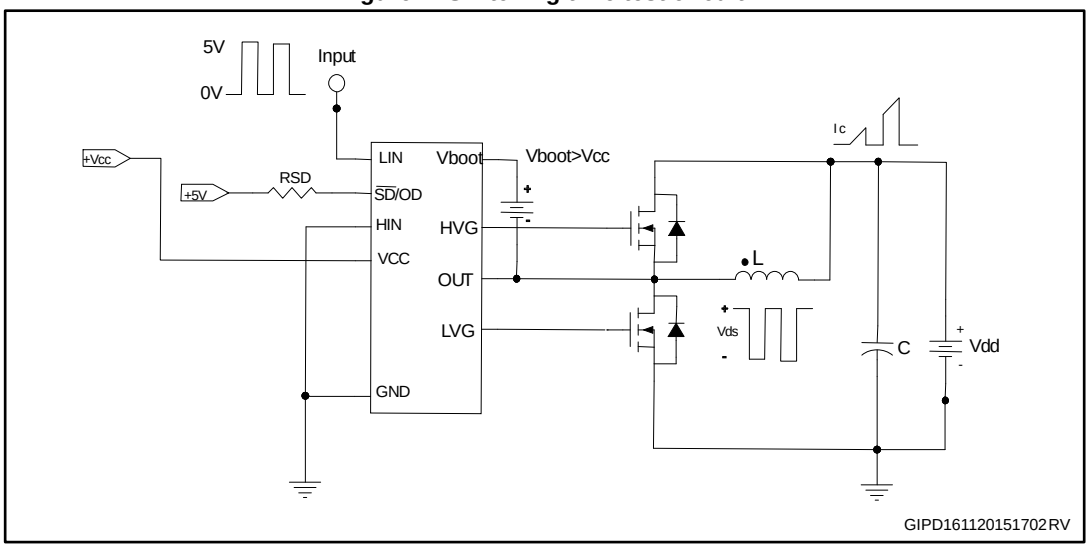


Figure 3: Switching time definition

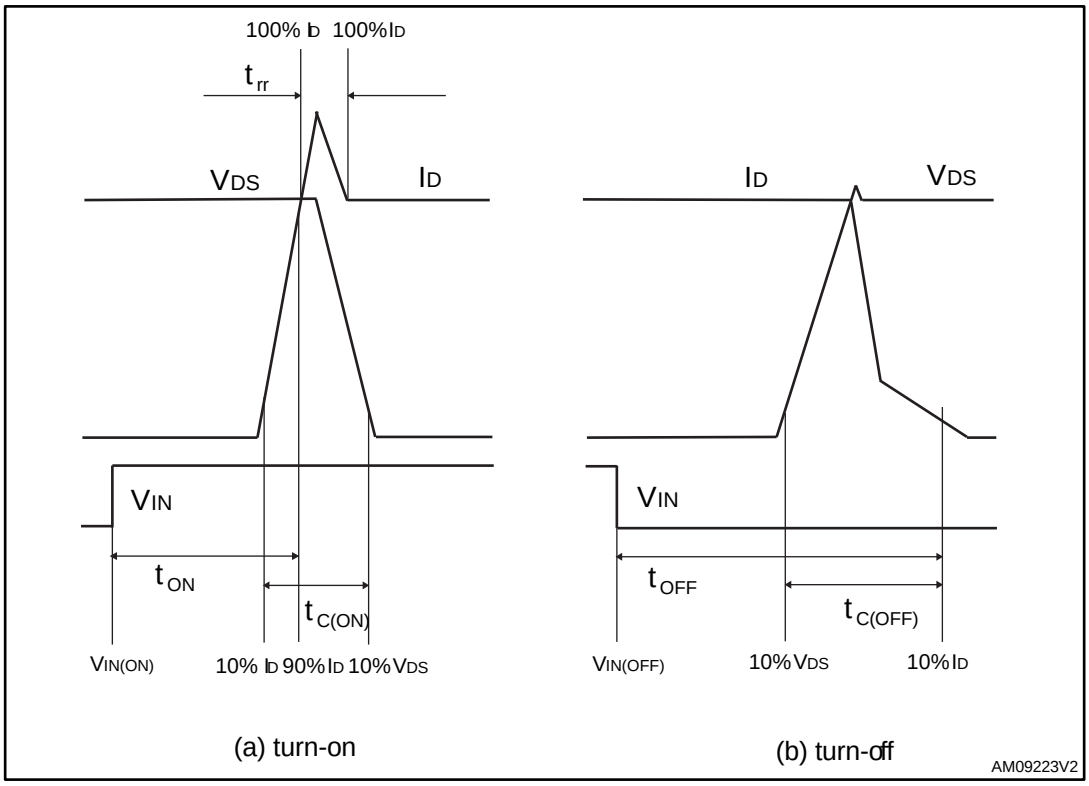


Figure 3: "Switching time definition" refers to HIN, LIN inputs (active high).

3.2 Control part

Table 9: Low voltage power supply (V_{CC} = 15 V unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
V_{CC_hys}	V_{CC} UV hysteresis		1.2	1.5	1.8	V
V_{CC_thON}	V_{CC} UV turn-ON threshold		11.5	12	12.5	V
V_{CC_thOFF}	V_{CC} UV turn-OFF threshold		10	10.5	11	V
I_{qccu}	Undervoltage quiescent supply current	V_{CC} = 10 V, T/$\overline{SD}$/OD = 5 V; LIN = 0 V; H_{IN} = 0 V, C_{IN} = 0 V			150	µA
I_{qcc}	Quiescent current	V_{cc} = 15 V, T/$\overline{SD}$/OD = 5 V; LIN = 0 V; H_{IN} = 0 V, C_{IN} = 0 V			1	mA
V_{ref}	Internal comparator (CIN) reference voltage		0.5	0.54	0.58	V

Table 10: Bootstrapped voltage (V_{CC} = 15 V unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
V_{BS_hys}	V_{BS} UV hysteresis		1.2	1.5	1.8	V
V_{BS_thON}	V_{BS} UV turn-ON threshold		11.1	11.5	12.1	V
V_{BS_thOFF}	V_{BS} UV turn-OFF threshold		9.8	10	10.6	V
I_{QBSU}	Undervoltage V_{BS} quiescent current	V_{BS} < 9 V, T/$\overline{SD}$/OD = 5 V; LIN = 0 V and HIN = 5 V; C_{IN} = 0 V		70	110	µA
I_{QBS}	V_{BS} quiescent current	V_{BS} = 15 V, T/$\overline{SD}$/OD = 5 V; LIN = 0 V and HIN = 5 V; C_{IN} = 0 V		200	300	µA
$R_{DS(on)}$	Bootstrap driver on-resistance	LVG ON		120		Ω

Table 11: Logic inputs (V_{CC} = 15 V unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
V_{il}	Low logic level voltage				0.8	V
V_{ih}	High logic level voltage		2.25			V
I_{HINh}	HIN logic “1” input bias current	HIN = 15 V	20	40	100	µA
I_{HINl}	HIN logic “0” input bias current	HIN = 0 V			1	µA
I_{LINl}	LIN logic “1” input bias current	LIN = 15 V	20	40	100	µA
I_{LINh}	LIN logic “0” input bias current	LIN = 0 V			1	µA
I_{SDh}	$\overline{SD}$ logic “0” input bias current	$\overline{SD}$ = 15 V	220	295	370	µA
I_{SDl}	$\overline{SD}$ logic “1” input bias current	$\overline{SD}$ = 0 V			3	µA
Dt	Dead time	see *Figure 8: "Dead time and interlocking waveform definitions"*		180		ns

Table 12: Op-amp characteristics (V_{CC} = 15 V unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
V_{io}	Input offset voltage	V_{ic} = 0 V, V_o = 7.5 V			6	mV
I_{io}	Input offset current	V_{ic} = 0 V, V_o = 7.5 V		4	40	nA
I_{ib}	Input bias current (1)			100	200	nA
V_{OL}	Low level output voltage	R_L = 10 kΩ to V_{CC}		75	150	mV
V_{OH}	High level output voltage	R_L = 10 kΩ to GND	14	14.7		V
I_o	Output short-circuit current	Source, V_{id} = +1 V; V_o = 0 V	16	30		mA
		Sink, V_{id} = -1 V; V_o = V_{CC}	50	80		mA
SR	Slew rate	V_i = 1 - 4 V; C_L = 100 pF; unity gain	2.5	3.8		V/µs
GBWP	Gain bandwidth product	V_o = 7.5 V	8	12		MHz
A_{vd}	Large signal voltage gain	R_L = 2 kΩ	70	85		dB
SVR	Supply voltage rejection ratio	vs. V_{CC}	60	75		dB
CMRR	Common mode rejection ratio		55	70		dB

Notes:

(1)The direction of the input current is out of the IC.

Table 13: Sense comparator characteristics (V_{CC} = 15 V unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
I_{ib}	Input bias current	V_{CIN} = 1 V			3	µA
V_{od}	Open-drain low level output voltage	I_{od} = 3 mA			0.5	V
R_{ON_OD}	Open-drain low level output resistance	I_{od} = 3 mA		166		Ω
R_{PD_SD}	$\overline{SD}$ pull-down resistor (1)			125		kΩ
t_{d_comp}	Comparator delay	T/$\overline{SD}$/OD pulled to 5 V through 100 kΩ resistor		90	130	ns
SR	Slew rate	C_L = 180 pF; R_{pu} = 5 kΩ		60		V/µsec
t_{sd}	Shutdown to high / low-side driver propagation delay	V_{OUT} = 0, V_{boot} = V_{CC}, V_{IN} = 0 to 3.3 V	50	125	200	ns
t_{isd}	Comparator triggering to high / low-side driver turn-off propagation delay	Measured applying a voltage step from 0 V to 3.3 V to pin CIN	50	200	250	

Notes:

(1)Equivalent values as a result of the resistances of three drivers in parallel.

Table 14: Truth table

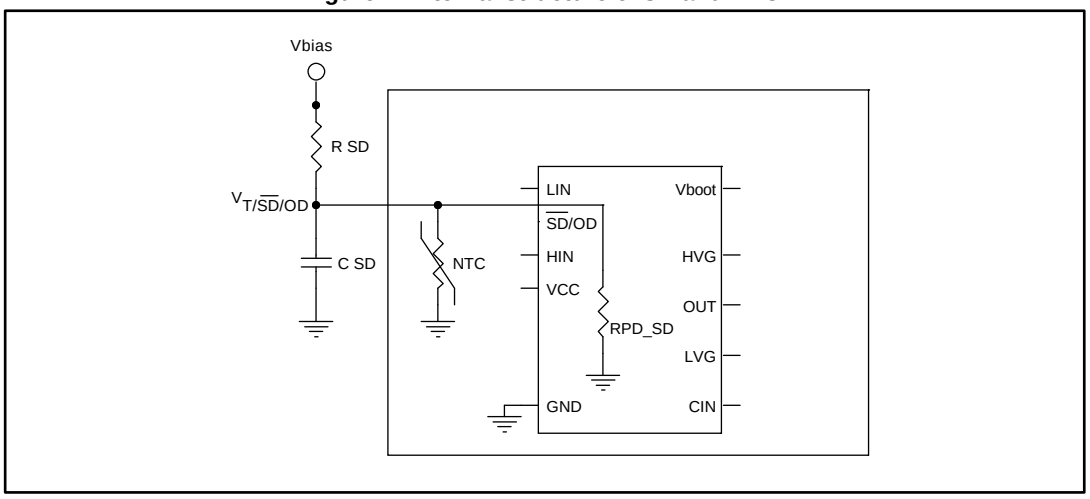
Conditions	Logic input (V_I)			Output	
	T/$\overline{SD}$/OD	LIN	HIN	LVG	HVG
Shutdown enable half-bridge tri-state	L	X(1)	X(1)	L	L
Interlocking half-bridge tri-state	H	H	H	L	L
0 “logic state” half-bridge tri-state	H	L	L	L	L
1 “logic state” low-side direct driving	H	H	L	H	L
1 “logic state” high-side direct driving	H	L	H	L	H

Notes:

(1)X: do not care.

3.2.1 NTC thermistor

Figure 4: Internal structure of $\overline{SD}$ and NTC



RPD_SD: equivalent value as result of resistances of three drivers in parallel.

Figure 5: Equivalent resistance (NTC//RPD_SD)

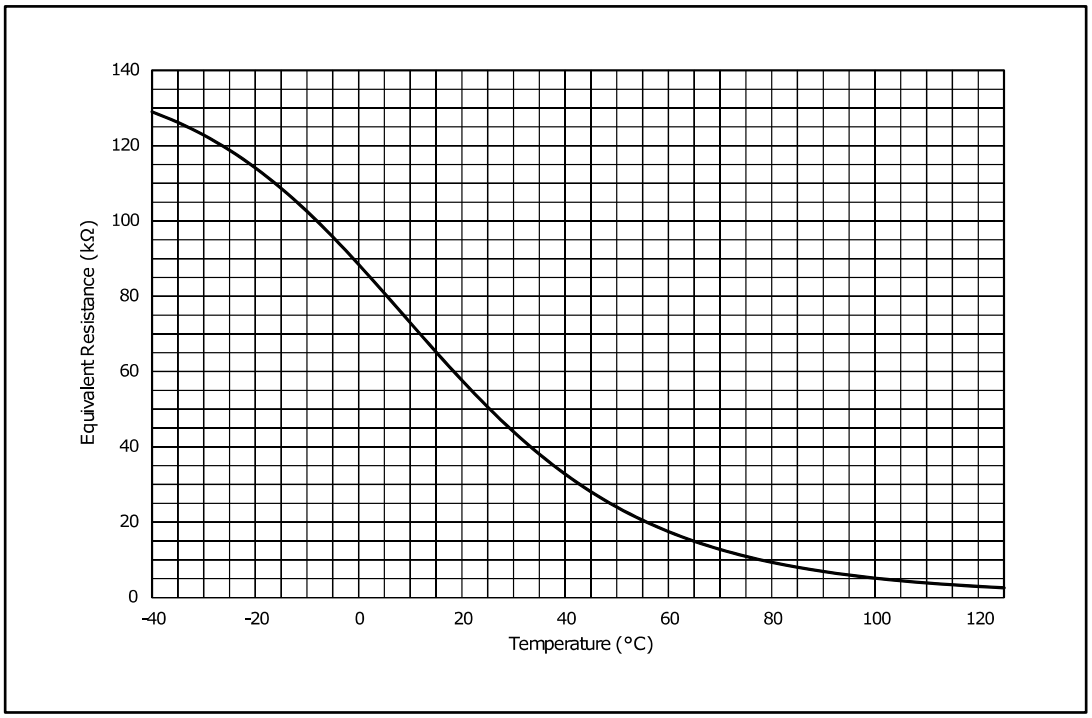


Figure 6: Equivalent resistance (NTC//RPD_SD) zoom

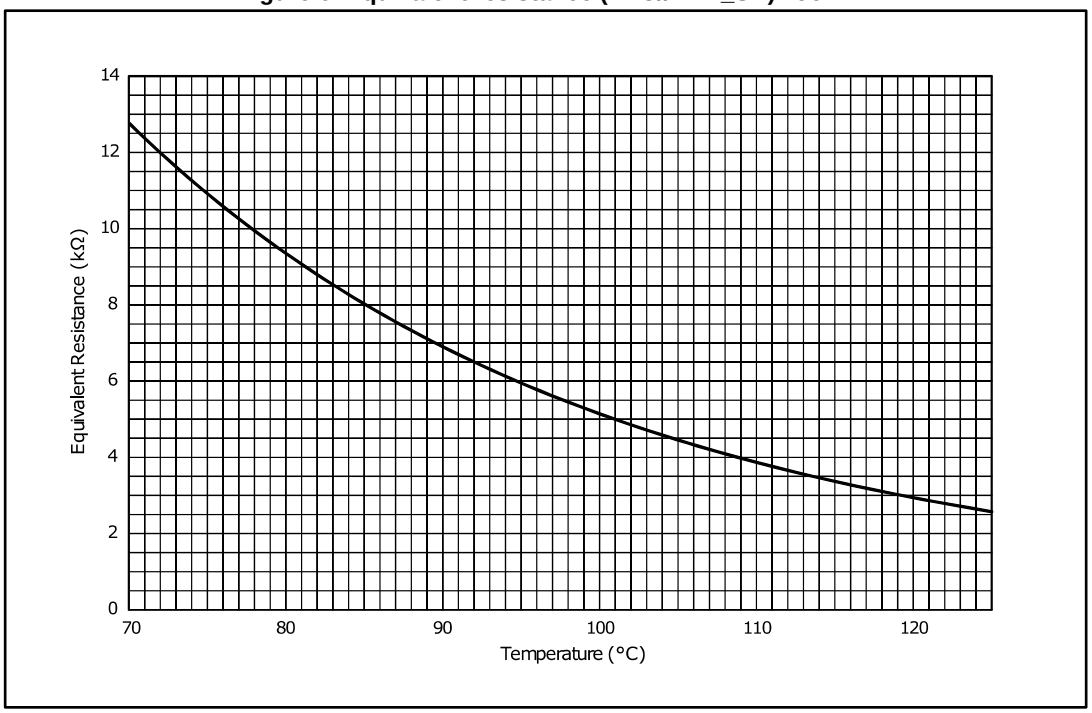
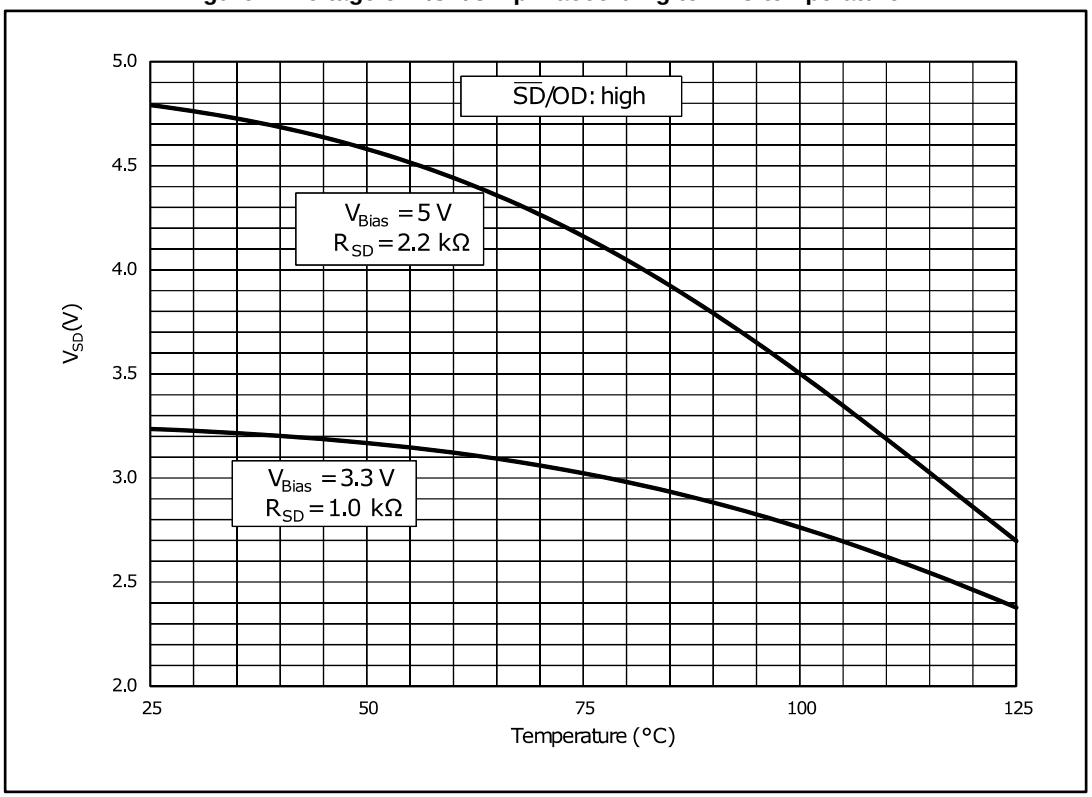
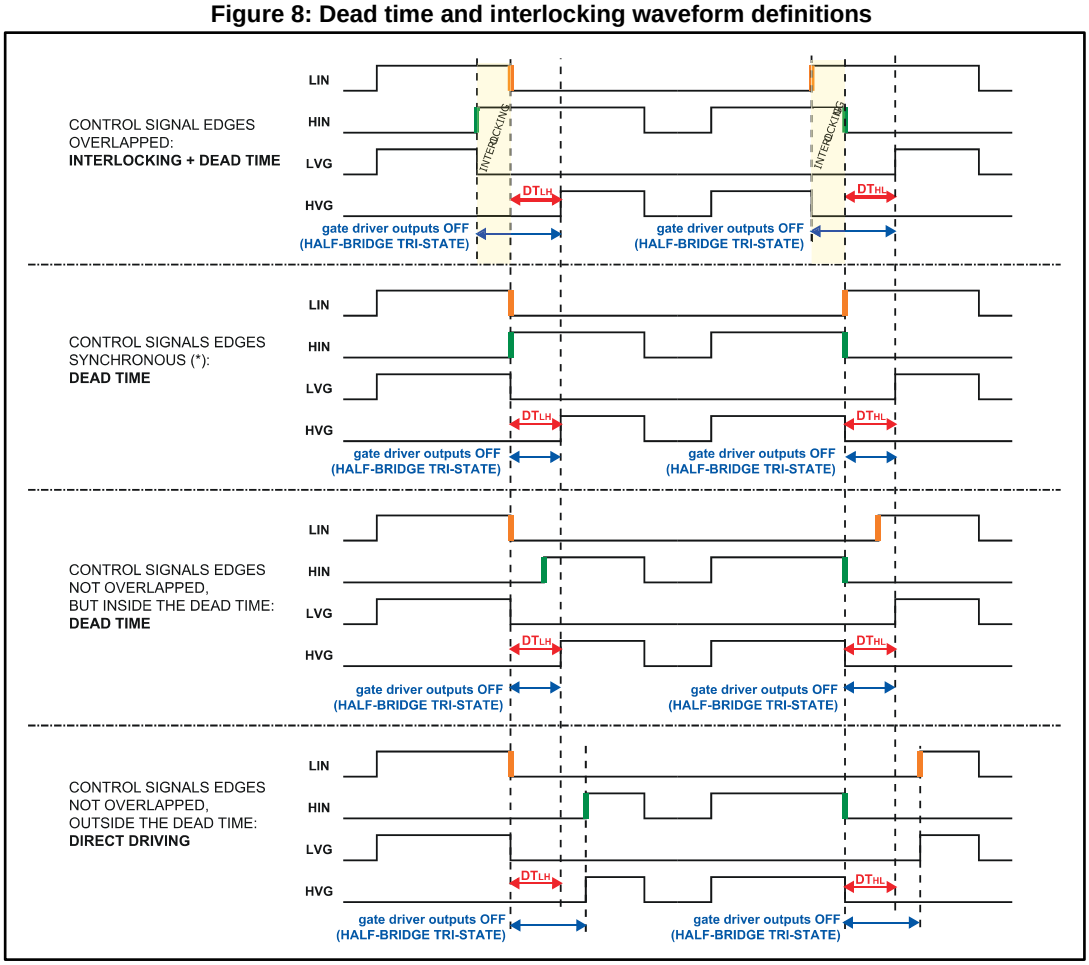


Figure 7: Voltage of T/$\overline{SD}$/OD pin according to NTC temperature



3.3 Waveform definitions

Figure 8: Dead time and interlocking waveform definitions



4 Smart shutdown function

The device integrates a comparator for fault sensing purposes. The comparator has an internal voltage reference V_{REF} connected to the inverting input, while the non-inverting input on pin (CIN) can be connected to an external shunt resistor for overcurrent protection.

When the comparator triggers, the device is set to the shutdown state and both of its outputs are set to low level, causing the half- bridge to enter a tri-state.

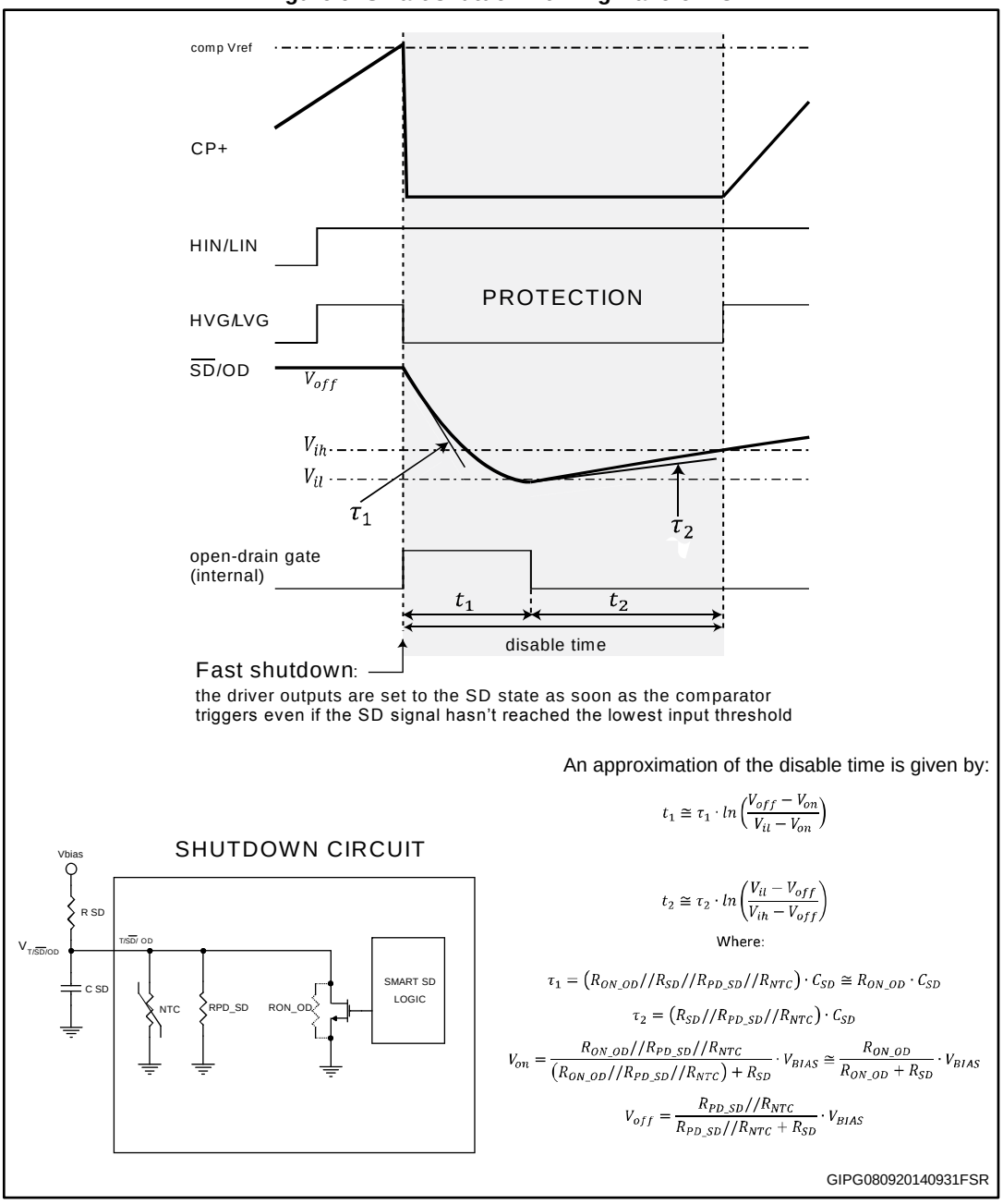
In common overcurrent protection architectures, the comparator output is usually connected to the shutdown input through an RC network so to provide a mono-stable circuit which implements a protection time following to fault condition.

Our smart shutdown architecture immediately turns off the output gate driver in case of overcurrent through a preferential path for the fault signal which directly switches off the outputs. The time delay between the fault and output shutdown no longer depends on the RC values of the external network connected to the shutdown pin. At the same time, the DMOS connected to the open-drain output (pin T/$\overline{SD}$/OD) is turned on by the internal logic, which holds it on until the shutdown voltage is well below the minimum value of logic input threshold (Vil).

Besides, the smart shutdown function allows the real disable time to be increased without rising the constant time of the external RC network.

NTC thermistor for temperature monitoring is internally connected in parallel to the $\overline{SD}$ pin. To avoid undesired shutdown, keep the voltage $V_{T/\overline{SD}/OD}$ higher than the high level logic threshold by setting the pull-up resistor $R_{\overline{SD}}$ to 1 kΩ or 2.2 kΩ for 3.3 V or 5 V MCU power supplies, respectively.

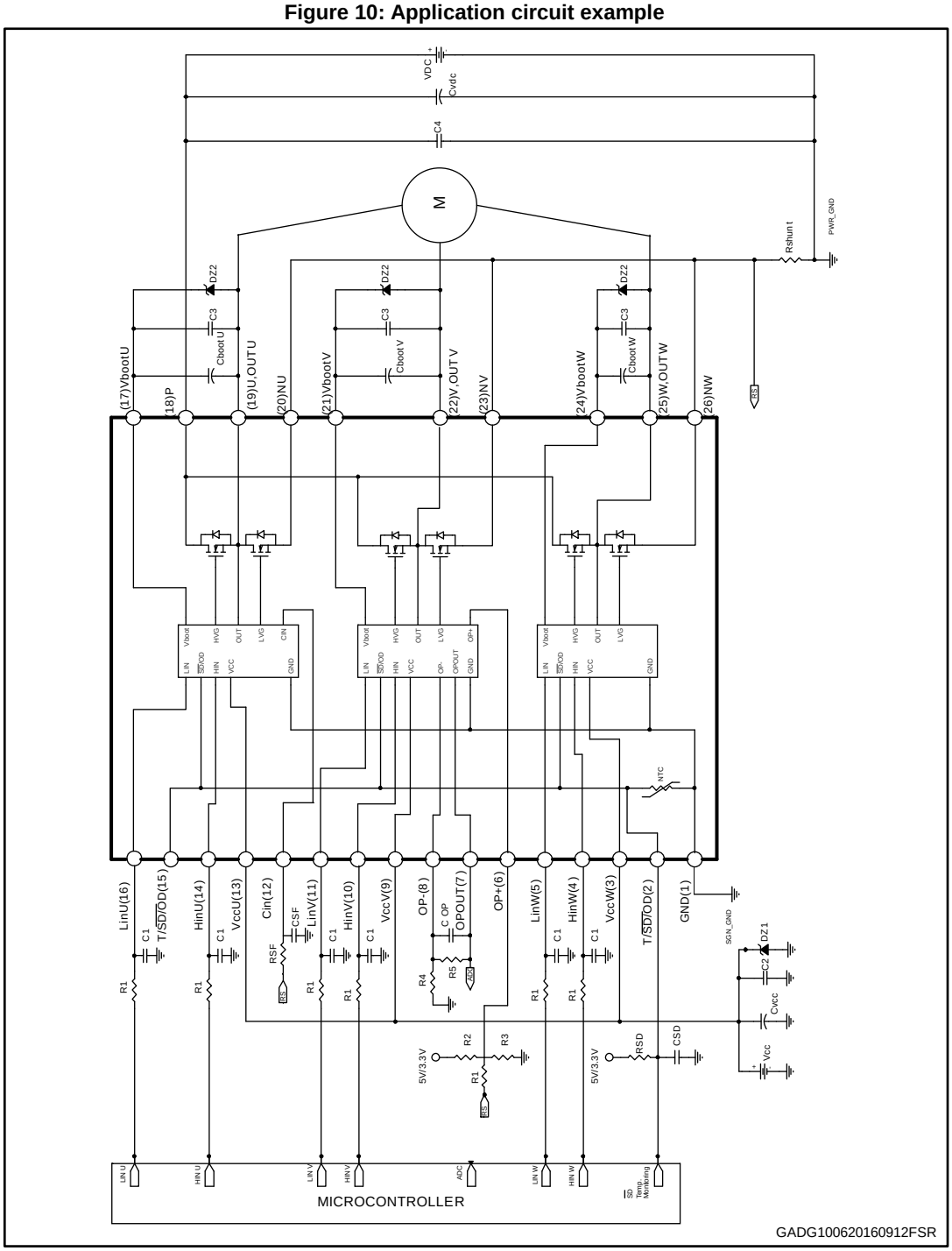
Figure 9: Smart shutdown timing waveforms



Please refer to *Table 13: "Sense comparator characteristics (VCC = 15 V unless otherwise specified)"* for internal propagation delay time details.

5 Application circuit example

Figure 10: Application circuit example



Application designers are free to use a different scheme according to the specifications of the device.

5.1 Guidelines

- Input signals HIN, LIN are active high logic. A 375 kΩ (typ.) pull-down resistor is built-in for each input. To prevent input signal oscillations, the wiring of each input should be as short as possible and the use of RC filters (R_1, C_1) on each input signal is suggested. The filters should be with a time constant of about 100 ns and placed as close as possible to the IPM input pins.
- The use of a bypass capacitor CVCC (aluminum or tantalum) helps to reduce the transient circuit demand on the power supply. Furthermore, to reduce high frequency switching noise distributed on the power lines, a decoupling capacitor C_2 (100 to 220 nF, with low ESR and low ESL) should be placed as close as possible to Vcc pin and in parallel with the bypass capacitor.
- The use of RC filter (RSF, CSF) is recommended to prevent protection circuit malfunction. The time constant (RSF x CSF) should be set to 1 µs and the filter must be placed as close as possible to the CIN pin.
- The $\overline{SD}$ is an input/output pin (open-drain type if used as output). A built-in thermistor NTC is internally connected between the $\overline{SD}$ pin and GND. The voltage VSD-GND decreases as the temperature increases, due to the pull-up resistor RSD. In order to keep the voltage always higher than the high level logic threshold, the pull-up resistor has to be set to 1 kΩ or 2.2 kΩ for 3.3 V or 5 V MCU power supply, respectively. The CSD capacitor of the filter on $\overline{SD}$ should be fixed no higher than 3.3 nF in order to assure $\overline{SD}$ activation time $\tau_1 \leq 500$ ns and the filter should be placed as close as possible to the $\overline{SD}$ pin.
- The decoupling capacitor C_3 (from 100 to 220 nF, ceramic with low ESR and low ESL), in parallel with each C_{boot}, filters high frequency disturbance. Both C_{boot} and C3 (if present) should be placed as close as possible to the U, V, W and V_{boot} pins. Bootstrap negative electrodes should be connected to U, V, W terminals directly and separated from the main output wires.
- To prevent the overvoltage on Vcc pin, a Zener diode (Dz1) can be used. Similarly on the V_{boot} pin, a Zener diode (Dz2) can be placed in parallel with each C_{boot}.
- The use of the decoupling capacitor C_4 (100 to 220 nF, with low ESR and low ESL) in parallel with the electrolytic capacitor C_{vdc} prevents surge destruction. Both capacitors C_4 and Cvdc should be placed as close as possible to the IPM (C4 has priority over C_{vdc}).
- By integrating an application-specific type HVIC inside the module, direct coupling to the MCU terminals without an optocoupler is possible.
- Low inductance shunt resistors for phase leg current sensing have to be used.
- In order to avoid malfunctions, the wiring on N pins, the shunt resistor and PWR_GND should be as short as possible.
- The connection of SGN_GND to PWR_GND to the point only (close to the shunt resistor terminal) reduces the impact of power ground fluctuation.

These guidelines ensure the specifications of the device for application designs. For further details, please refer to the relevant application note.

Table 15: Recommended operating conditions

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
V_{PN}	Supply voltage	Applied among P-Nu, Nv, Nw		300	500	V
V_{CC}	Control supply voltage	Applied to V_{CC}-GND	13.5	15	18	V
V_{BS}	High-side bias voltage	Applied to V_{BOOTi}-OUT_i for i = U, V, W	13		18	V
t_{dead}	Blanking time to prevent arm-short	For each input signal	1			µs
f_{PWM}	PWM input signal	-40 °C < T_c < 100 °C -40 °C < T_j < 125 °C			25	kHz
T_C	Case operation temperature				100	°C

6 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: ***www.st.com***. ECOPACK® is an ST trademark.

6.1 N2DIP-26L type L package information

Figure 11: N2DIP-26L type L package outline

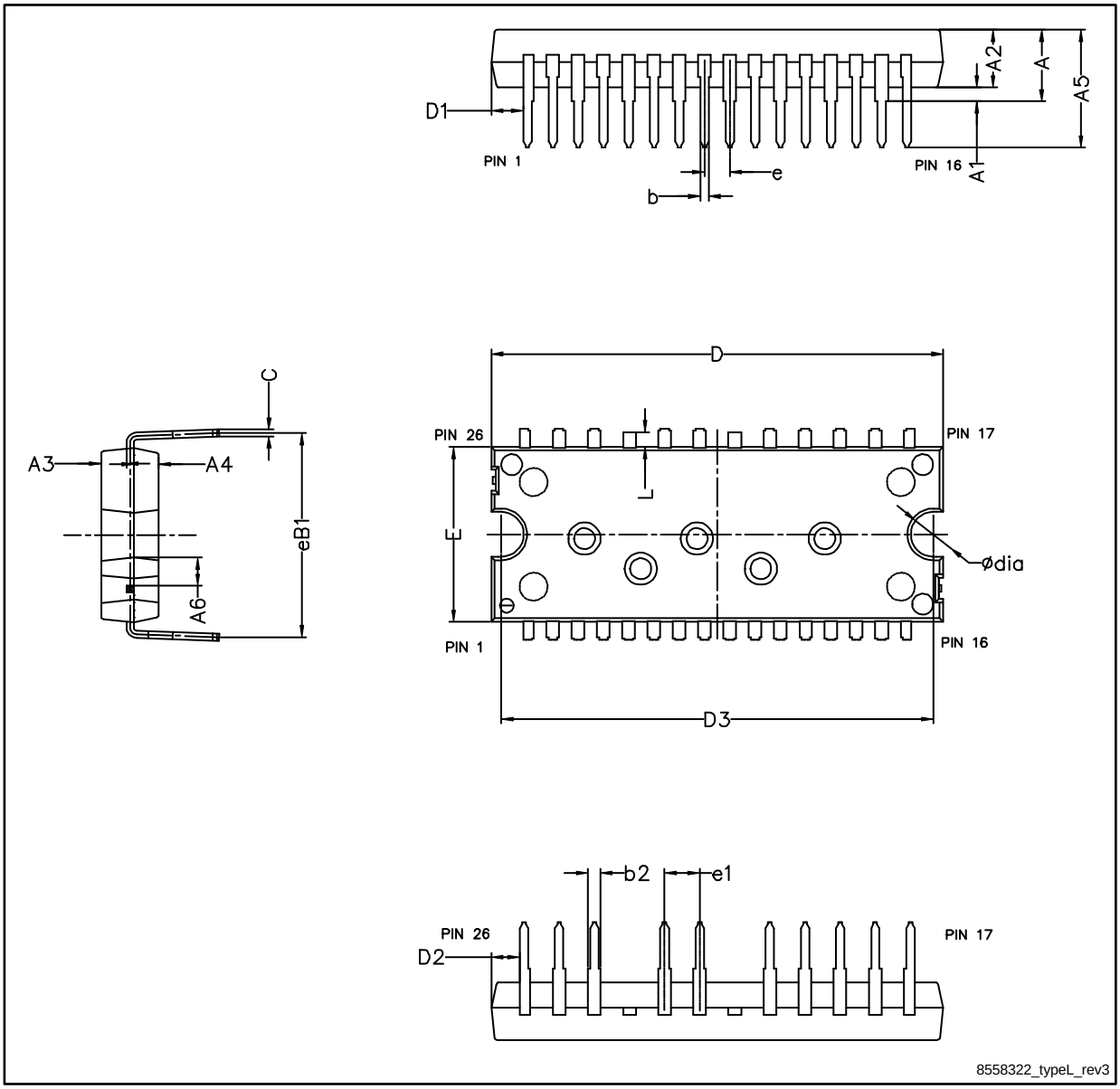


Table 16: N2DIP-26L type L mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A	4.80	5.10	5.40
A1	0.80	1.00	1.20
A2	4.00	4.10	4.20
A3	1.70	1.80	1.90
A4	1.70	1.80	1.90
A5	8.10	8.40	8.70
A6	1.75		
b	0.53		0.72
b2	0.83		1.02
c	0.46		0.59
D	32.05	32.15	32.25
D1	2.10		
D2	1.85		
D3	30.65	30.75	30.85
E	12.35	12.45	12.55
e	1.70	1.80	1.90
e1	2.40	2.50	2.60
eB1	14.25	14.55	14.85
L	0.85	1.05	1.25
Dia	3.10	3.20	3.30

6.2 N2DIP-26L type Z package information

Figure 12: N2DIP-26L type Z package outline

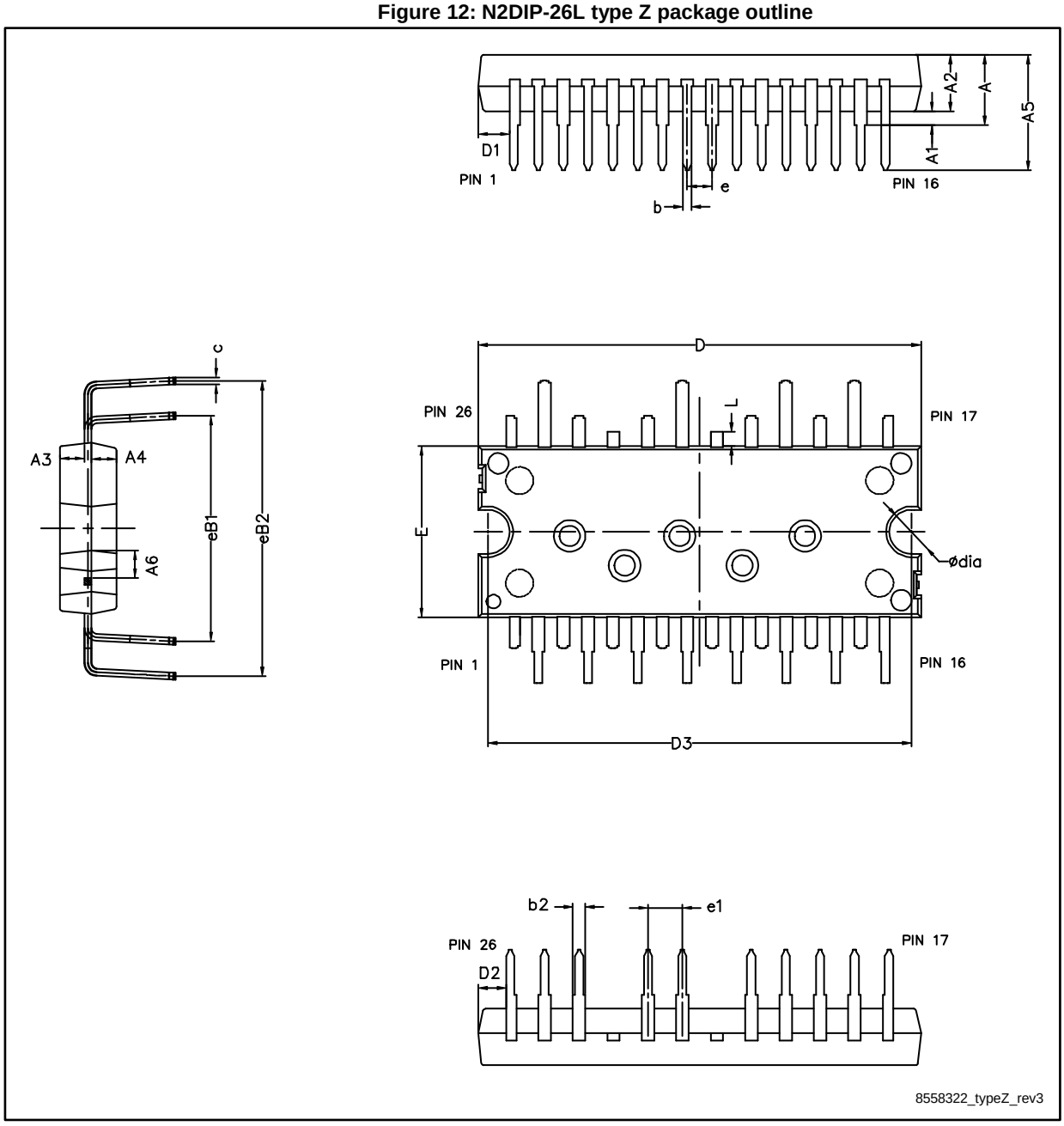
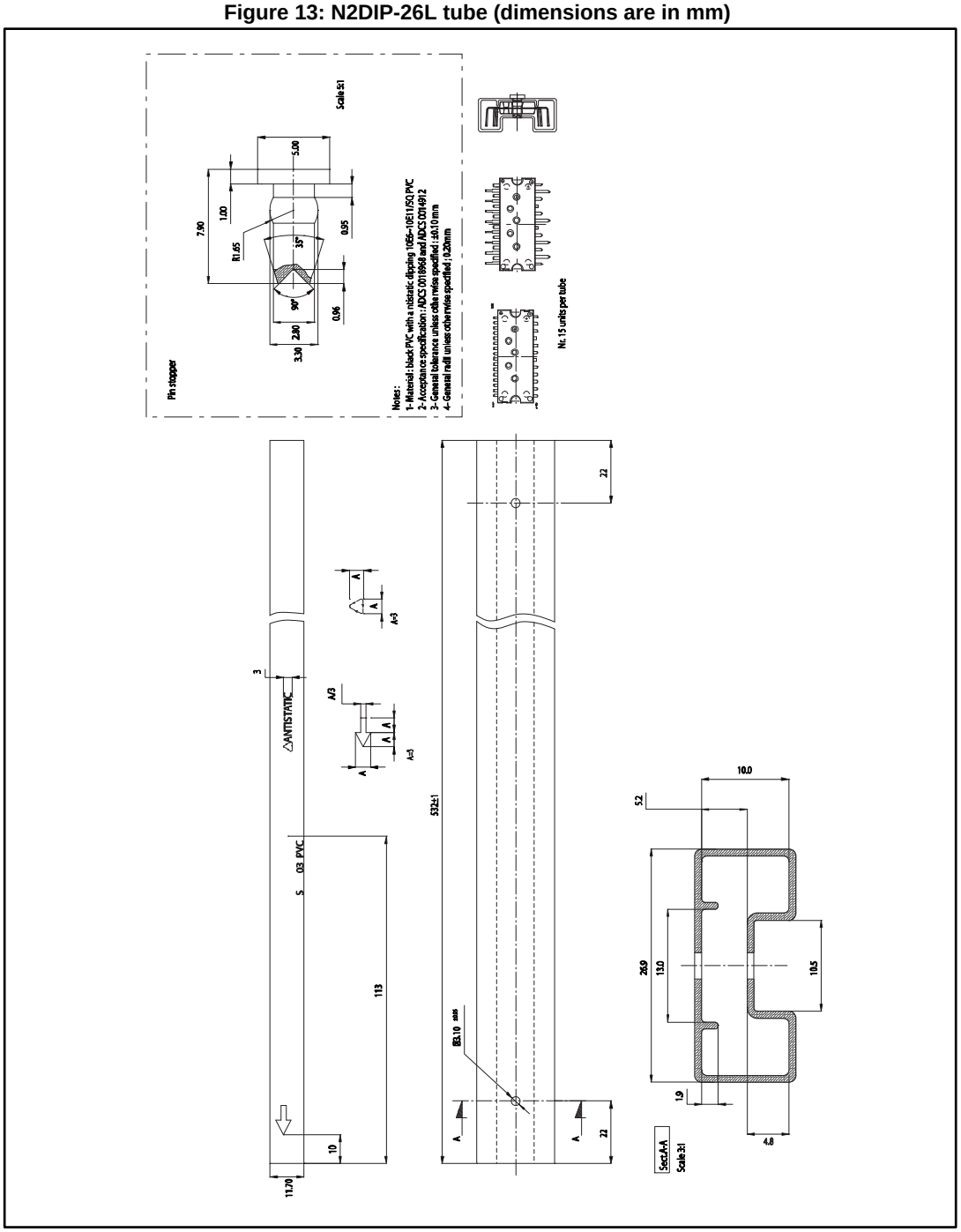


Table 17: N2DIP-26L type Z mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A	4.80	5.10	5.40
A1	0.80	1.00	1.20
A2	4.00	4.10	4.20
A3	1.70	1.80	1.90
A4	1.70	1.80	1.90
A5	8.10	8.40	8.70
A6	1.75		
b	0.53		0.72
b2	0.83		1.02
c	0.46		0.59
D	32.05	32.15	32.25
D1	2.10		
D2	1.85		
D3	30.65	30.75	30.85
E	12.35	12.45	12.55
e	1.70	1.80	1.90
e1	2.40	2.50	2.60
eB1	16.10	16.40	16.70
eB2	21.18	21.48	21.78
L	0.85	1.05	1.25
Dia	3.10	3.20	3.30

6.3 N2DIP-26L packing information

Figure 13: N2DIP-26L tube (dimensions are in mm)



7 Revision history

Table 18: Document revision history

Date	Revision	Changes
17-Jan-2017	1	Initial release.
09-Jun-2017	2	Modified features on cover page. Datasheet promoted from preliminary data to production data. Updated *Section 6: "Package information"*. Minor text changes.

IMPORTANT NOTICE – PLEASE READ CAREFULLY

STMicroelectronics NV and its subsidiaries (“ST”) reserve the right to make changes, corrections, enhancements, modifications, and improvements to ST products and/or to this document at any time without notice. Purchasers should obtain the latest relevant information on ST products before placing orders. ST products are sold pursuant to ST’s terms and conditions of sale in place at the time of order acknowledgement.

Purchasers are solely responsible for the choice, selection, and use of ST products and ST assumes no liability for application assistance or the design of Purchasers’ products.

No license, express or implied, to any intellectual property right is granted by ST herein.

Resale of ST products with provisions different from the information set forth herein shall void any warranty granted by ST for such product.

ST and the ST logo are trademarks of ST. All other product or service names are the property of their respective owners.

Information in this document supersedes and replaces information previously supplied in any prior versions of this document.